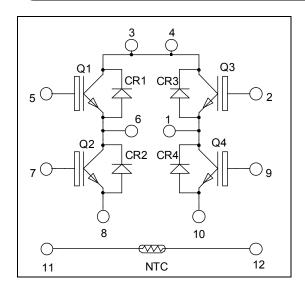
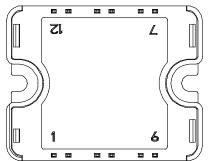


### Full bridge High speed Trench + Field Stop IGBT4 Power Module

$$V_{CES} = 650V$$
  
 $I_{C} = 75A$  @  $Tc = 60$ °C





Pins 3/4 must be shorted together

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- High speed Trench + Field Stop IGBT 4 Technology
  - Low voltage drop
  - Low leakage current
  - Low switching losses
  - RBSOA and SCSOA rated
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS compliant

### All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

### Absolute maximum ratings (per IGBT)

Symbol	Parameter		Max ratings	Unit
$V_{CES}$	Collector - Emitter Voltage		650	V
Ţ	Continuous Collector Current	$T_C = 25^{\circ}C$	100	
$I_{C}$	Continuous Conector Current	$T_C = 60$ °C	75	Α
$I_{CM}$	Pulsed Collector Current	$T_C = 25$ °C	200	
$V_{GE}$	Gate – Emitter Voltage		±20	V
$P_{D}$	Maximum Power Dissipation		250	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 150^{\circ}C$	150A @ 600V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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**Electrical Characteristics** (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 650V$				100	μΑ
V <sub>CE(sat)</sub>	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25$ °C		1.85	2.3	17
		$I_C = 75A \qquad T_j = 1$	$T_j = 150$ °C		2.2		·
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 1.2 \text{ mA}$		4.2	5.1	5.6	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				200	nA

**Dynamic Characteristics** (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$	$V_{GE} = 0V$		4620		
$C_{oes}$	Output Capacitance	$V_{CE} = 25V$			160		pF
$C_{res}$	Reverse Transfer Capacitance	f = 1MHz	f = 1MHz		137		
$Q_{G}$	Gate charge	$V_{GE} = 15V, I_C$ $V_{CE} = 480V$	$V_{GE} = 15V, I_C = 75A$ $V_{CE} = 480V$		440		nC
$T_{d(on)}$	Turn-on Delay Time	Inductive Swit	tching (25°C)		19		
$T_{r}$	Rise Time	$V_{GE} = \pm 15V$			33		ns
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{C}} = 75A$			197		
$T_{\mathrm{f}}$	Fall Time	$R_G = 5\Omega$			21		
$T_{d(on)}$	Turn-on Delay Time		tching (150°C)		19		
$T_{\rm r}$	Rise Time	$V_{GE} = \pm 15V$ $V_{Bus} = 400V$ $I_{C} = 75A$ $R_{G} = 5\Omega$			29		ns
$T_{d(off)}$	Turn-off Delay Time				227		
$T_{\mathrm{f}}$	Fall Time				22		
E <sub>on</sub>	Turn on Energy	$V_{GE} = \pm 15V$	$T_i = 25^{\circ}C$		1.5		
Lon	Turn on Energy	$V_{Bus} = 400V$			1.8		mJ
$E_{off}$	Turn off Energy	$I_C = 75A$	$T_i = 25$ °C		1.25		1110
011	- 67	$R_G = 5\Omega$	$T_{i} = 150^{\circ}C$		1.4		
$I_{sc}$	Short Circuit data	$V_{GE} \le 15V ; V_{I}$ $t_{p} \le 5\mu s ; T_{j} = 1$			500		A
$R_{thJC}$	Junction to Case Thermal Resistance		•			0.6	°C/W

Diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_{RRM}$	Peak Repetitive Reverse Voltage					650	V
$I_{RM}$	Reverse Leakage Current	$V_R = 650V$				100	μΑ
$I_{\mathrm{F}}$	DC Forward Current		$Tc = 25^{\circ}C$		75		A
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_F = 75A$ $V_{GE} = 0V$	$T_i = 25^{\circ}C$		1.6	2	V
V F	Diode I of ward Voltage		$T_i = 150$ °C		1.5		V
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 75A$ $V_R = 400V$ $di/dt = 2000A/\mu s$	$T_j = 25$ °C		100		ns
r <sub>rr</sub>	Reverse Recovery Time		$T_{\rm j} = 150^{\circ}{\rm C}$		150		113
$Q_{rr}$	Reverse Recovery Charge		$T_j = 25^{\circ}C$		3.6		μС
Vп	Reverse Recovery Charge		$T_{j} = 150^{\circ}C$		7.6		μС
$E_{rr}$	· ·	$T_j = 25^{\circ}C$		0.85		mJ	
L <sub>rr</sub>	Reverse Recovery Energy		$T_{j} = 150^{\circ}C$		1.8		1113
$R_{thJC}$	Junction to Case Thermal Resistance					0.98	°C/W



### $\label{thm:complex} \textbf{Temperature sensor NTC} \ \ (\text{see application note APT0406 on www.microsemi.com}).$

Symbol	Characteristic		Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C	ce @ 25°C		50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		$T_C=100$ °C		4		%

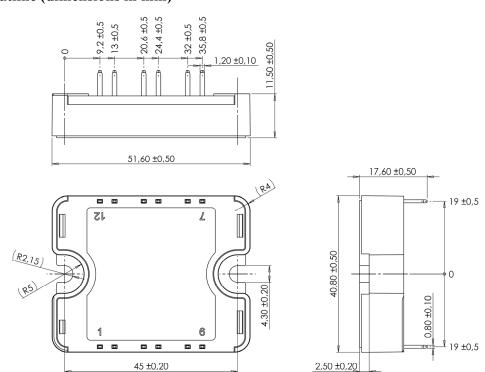
$$R_T = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$

$$R_T: \text{ Thermistor value at T}$$

#### Thermal and package characteristics

Symbol	Characteristic	Min	Max	Unit		
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz					V
$T_{J}$	Operating junction temperature range			-40	175	
$T_{JOP}$	Recommended junction temperature under switching conditions				T <sub>J</sub> max -25	°C
$T_{STG}$	Storage Temperature Range			-40	125	C
$T_{\rm C}$	Operating Case Temperature				100	
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				80	g

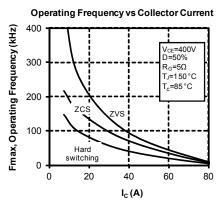
### Package outline (dimensions in mm)

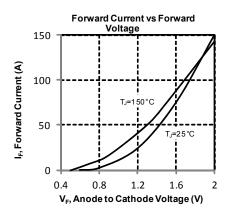


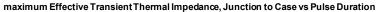
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

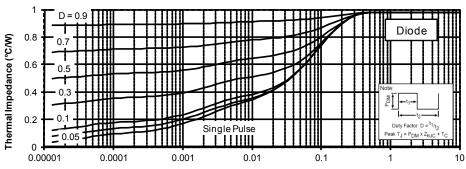


### Typical performance curve





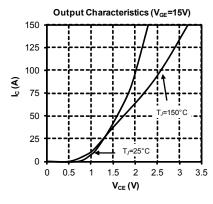


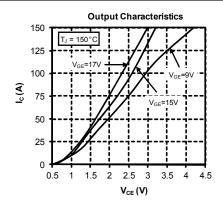


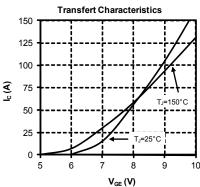
Rectangular Pulse Duration in Seconds

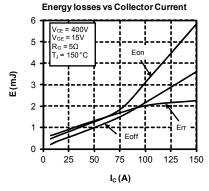
4 - 6

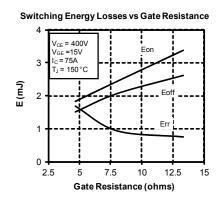


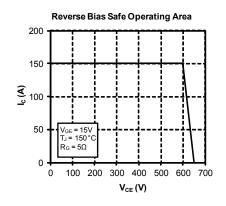


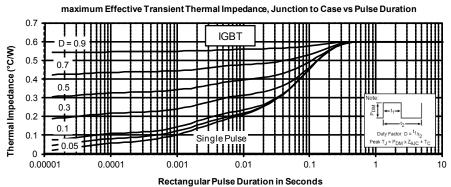












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